OKI Semiconductor MSM56V16800F

This version: November. 2000 Previous version : —

2-Bank × 1,048,576-Word × 8-Bit SYNCHRONOUS DYNAMIC RAM

DESCRIPTION

The MSM56V16800F is a 2-Bank \times 1,048,576-word \times 8-bit Synchronous dynamic RAM fabricated in Oki's silicon-gate CMOS technology. The device operates at 3.3V. The inputs and outputs are LVTTL compatible.

FEATURES

- · Silicon gate, quadruple polysilicon CMOS, 1-transistor memory cell
- \cdot 2-Bank \times 1,048,576-word \times 8-bit configuration
- \cdot Single 3.3V power supply, ±0.3V tolerance
- · Input : LVTTL compatible
- Output : LVTTL compatible
- · Refresh : 4096 cycles/64ms
- · Programmable data transfer mode
 - CAS Latency (1,2,3)
 - Burst Length (1,2,4,8,Full Page)
 - Data scramble (sequential, interleave)
- · CBR auto-refresh, Self-refresh capability

· Packages:

44-pin 400mil plastic TSOP (TypeII) (TSOPII44-P-400-0.80-1K)(Product : MSM56V16800F-xxTS-K) xx indicates speed rank.

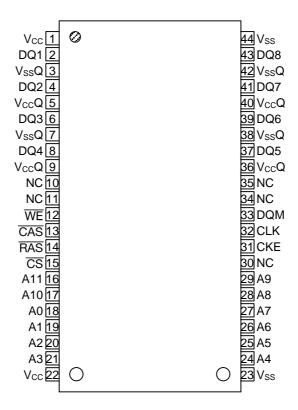
PRODUCT FAMILY

Fomily	Max.	Access Time (Max.)			
Family	Frequency	t _{AC2}	t _{AC3}		
MSM56V16800F-8A	125MHz	6ns	6ns		
MSM56V16800F-10	100MHz	9ns	9ns		

FEDD56V16800F-01

MSM56V16800F

PIN CONFIGURATION (TOP VIEW)



44-Pin Plastic TSOP (K Type)

Pin Name	Function	Pin Name	Function
CLK	System Clock	DQM	Data Input/ Output Musk
CS	Chip Select	DQi	Data Input/ Output
CKE	Clock Enable	V _{CC}	Power Supply (3.3V)
A0–A10	Address	V _{SS}	Ground (0V)
A11	Bank Select Address	V _{CC} Q	Data Output Power Supply (3.3V)
RAS	Row Address Strobe	V _{SS} Q	Data Output Ground (0V)
CAS	Column Address Strobe	NC	No Connection
WE	Write Enable		

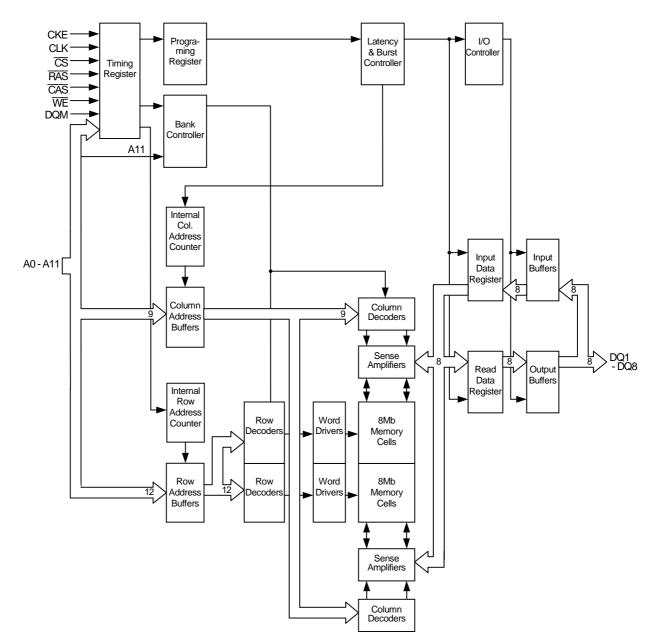
Note : The same power supply voltage must be provided to every V_{CC} pin and V_{CC}Q pin.

The same GND voltage level must be provided to every V_{SS} pin and $V_{SS}Q$ pin.

PIN DESCRIPTION

CLK	Fetches all inputs at the "H" edge.
CS	Disables or enables device operation by asserting or deactivating all inputs except CLK, CKE, DQM.
CKE	Masks system clock to deactivate the subsequent CLK operation. If CKE is deactivated, system clock will be masked so that the subsequent CLK operation is deactivated. CKE should be asserted at least one cycle prior to a new command.
Address	Row & column multiplexed. Row address : RA0 – RA10 Column Address : CA0 – CA8
A11	Slects bank to be activated during row address latch time and selects bank for precharge and read/write during column address latch time. A11="L" : Bank A, A11="H" : Bank B
RAS CAS WE	Functionality depends on the combination. For details, see the function truth table.
DQM	Masks the read data of two clocks later when DQM is set "H" at the "H" edge of the clock signal. Masks the write data of the same clock when DQM is set "H" at the "H" edge of the clock signal.
DQi	Data inputs/outputs are multiplexed on the same pin.

BLOCK DIAGRAM



ELECTRICAL CHARACTERISTICS

ABSOLUTE MAXIMUM RATINGS

(Voltages referenced					
Parameter	Symbol	Value	Unit		
Voltage on Any Pin Relative to V_{SS}	V _{IN} , V _{OUT}	–0.5 to V _{CC} + 0.5	V		
V _{CC} Supply Voltage	V_{CC} , $V_{CC}Q$	-0.5 to 4.6	V		
Storage Temperature	T _{stg}	-55 to 150	°C		
Power Dissipation	P _{D*}	600	mW		
Short Circuit Output Current	I _{OS}	50	mA		
Operating Temperature	T _{opr}	0 to 70	°C		
	*: Ta = 25°C				

RECOMMENDED OPERATIING CONDITIONS

(Voltages referenced to $V_{SS} = 0V$)

Parameter	Symbol	Min.	Тур.	Max.	Unit
Power Supply Voltage	$V_{CC}, V_{CC}Q$	3.0	3.3	3.6	V
Input High Voltage	V _{IH}	2.0	_	Vcc + 0.2	V
Input Low Voltage	V _{IL}	- 0.3	_	0.8	V

PIN CAPACITANCE

 $(V_{BIAS} = 1.4V, Ta = 25^{\circ}C, f = 1 MHz)$

Parameter	Symbol	Min.	Max.	Unit
Input Capacitance (CLK)	C _{CLK}	2.5	4	pF
Input Capacitance (RAS, CAS, WE, CS, CKE, DQM, A0 - A11)	C _{IN}	2.5	5	pF
Input/Output Capacitance (DQ1 - DQ8)	C _{OUT}	4	6.5	pF

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MSM56V16800F

DC CHARACTERISTICS

					MSM56V16800				Unit	Note
Parameter	Symbol		Condition		F-8A		F-10			
		Bank	CKE	Others	Min.	Max.	Min.	Max.		
Output High Voltage	V _{ОН}			I _{OH} = _2.0mA	2.4	_	2.4		V	
Output Low Voltage	V _{OL}			I _{OL} = 2.0mA		0.4	_	0.4	V	
Input Leakage Current	ILI				- 10	10	- 10	10	μA	
Output Leakage Current	ILO				- 10	10	- 10	10	μA	
Average Power	I _{CC1}	One Bank Active	CKE≥V _{IH}	t _{CC} = Min. t _{RC} = Min. No Burst	_	80		70	mA	1,2
Supply Current (Operating)	I _{CC1D}	Both Banks Active	CKE≥V _{IH}	t _{CC} = Min. t _{RC} = Min. t _{RRD} = Min. No Burst		115		95	mA	1,2
Power Supply Current (Standby)	I _{CC2}	Both Banks Precharge	CKE≥V _{IH}	t _{CC} = Min.	_	35		30	mA	3
Average Power Supply Current (Clock Suspension)	I _{CC3S}	Both Banks Active	CKE≤V _{IL}	t _{CC} = Min.		3		3	mA	2
Average Power Supply Current (Active Standby)	I _{CC3}	One Bank Active	CKE≥V _{IH}	t _{CC} = Min.	_	40		35	mA	3
Power Supply Current (Burst)	I _{CC4}	Both Banks Active	CKE≥V _{IH}	t _{CC} = Min.	_	125		100	mA	1,2
Power Supply Current (Auto-Refresh)	I _{CC5}	One Bank Active	CKE≥V _{IH}	t _{CC} = Min. t _{RC} = Min.		80		70	mA	2
Average Power Supply Current (Self-Refresh)	I _{CC6}	Both Banks Precharge	CKE≤ V _{IL}	t _{CC} = Min.		2		2	mA	
Average Power Supply Current (Power Down)	I _{CC7}	Both Banks Precharge	CKE≤V _{IL}	t _{CC} = Min.		2		2	mA	

Notes: 1. Measured with outputs open.

The address and data can be changed once or left unchanged during one cycle.
The address and data can be changed once or left unchanged during two cycle.

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Mode Set Address Keys

	CA	S Late	ency Burst Type		Burst Type	Burst Length				
A6	A5	A4	CL	A3	BT	A2	A1	A0	BT = 0	BT = 1
0	0	0	Reserved	0	Sequential	0	0	0	1	1
0	0	1	1	1	Interleave	0	0	1	2	2
0	1	0	2			0	1	0	4	4
0	1	1	3			0	1	1	8	8
1	0	0	Reserved			1	0	0	Reserved	Reserved
1	0	1	Reserved			1	0	1	Reserved	Reserved
1	1	0	Reserved			1	1	0	Reserved	Reserved
1	1	1	Reserved			1	1	1	Full Page	Reserved

Notes: A7, A8, A9, A10 and A11 should stay "L" during mode set cycle.

MSM56V16800F support two methods of Power on Sequence.

POWER ON SEQUENCE 1

- 1. With inputs in NOP state, turn on the power supply and start the system clock.
- 2. After the V_{CC} voltage has reached the specified level, pause for 200 μ s or more with the input kept in NOP state.
- 3. Issue the precharge all bank command.
- 4. Apply a CBR auto-refresh eight or more times.
- 5. Enter the mode register setting command.

POWER ON SEQUENCE 2

- 1. With inputs in NOP state, turn on the power supply and start the system clock.
- 2. After the V_{CC} voltage has reached the specified level, pause for 200 μ s or more with the input kept in NOP state.
- 3. Issue the precharge all bank command.
- 4. Enter the mode register setting command.
- 5. Apply a CBR auto-refresh eight or more times.

FEDD56V16800F-01

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AC CHARACTERISTICS (1/2)

Paramete	r	Symbol	MSM56' F-8		MSM56 F-		Unit	Note
			Min.	Max.	Min.	Max.		
	CL = 3	t _{CC3}	8	—	10		ns	
Clock Cycle Time	CL = 2	t _{CC2}	10	—	15	_	ns	
	CL = 1	t _{CC1}	20	—	30	_	ns	
	CL = 3	t _{AC3}	_	6	_	9	ns	3,4
Access Time from Clock	CL = 2	t _{AC2}	_	6	_	9	ns	3,4
	CL = 1	t _{AC1}	_	16		27	ns	3,4
Clock High Pulse Ti	me	^t CH	3	_	3	_	ns	4
Clock Low Pulse Tir	ne	t _{CL}	3	_	3	_	ns	4
Input Setup Time		t _{SI}	2	_	3	_	ns	
Input Hold Time		t _{HI}	1	_	1	_	ns	
Output Low Impeda from Clock	Output Low Impedance Time from Clock		3	_	3		ns	
Output High Impeda from Clock	Output High Impedance Time from Clock			8	_	8	ns	
Output Hold from Cl	ock	t _{ОН}	3		3	_	ns	3
Random Read or Write	e Cycle Time	t _{RC}	70		90	_	ns	
RAS Precharge Time		t _{RP}	20		30	_	ns	
RAS Pulse Width		t _{RAS}	48	100,000	60	100,000	ns	
RAS to CAS Delay Tin	ne	t _{RCD}	20		30	_	ns	
Write Recovery Time		t _{WR}	8		15	_	ns	
RAS to CAS Bank Act	ive Delay	t _{RRD}	20	_	20	_	ns	
Refresh Time		t _{REF}	_	64	_	64	ms	
Power-down Exit setup Time		^t RDE	t _{SI} +1CLK	_	t _{SI} +1CLK	_	ns	
Input Level Transition Time		t _T	_	3	_	3	ns	
CAS to CAS Delay Time (Min.)		tCCD	1	•	1		Cycle	
Clock Disable Time fro	om CKE	^t CKE	1		1		Cycle	
Data Output High Imp from DQM	edance Time	t _{DOZ}	2		2		Cycle	
Dada Input Mask Time	e from DQM	tDOD	C)	C)	Cycle	

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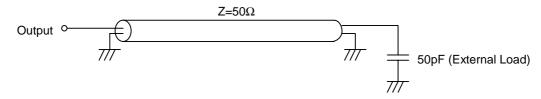
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AC CHARACTERISTICS (2/2)

						١	lote1,2
Parameter	Symbol	MSM56V16800 F-8A		MSM56V16800 F-10		Unit	Note
		Min.	Max.	Min.	Max.		
Data Input Mask Time from Write Command	^t DWD	0		0		Cycle	
Data Output High Impedance Time from Precharge Command	^t ROH	CL		CL		Cycle	
Active Command Input Time from Mode Register Set Command Input (Min.)	t _{MRD}	2		2 2		Cycle	
Write Command Input Time from Outpput	towd	2		2		Cycle	

Notes: 1. AC measurements assume that $t_T = 1$ ns.

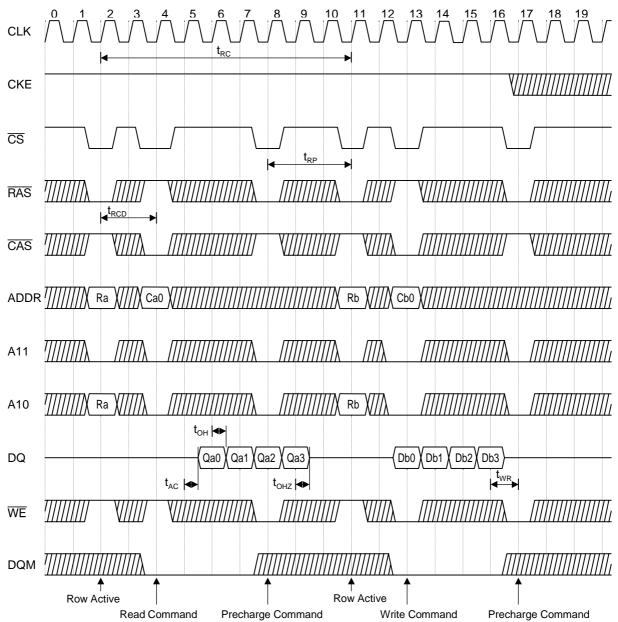
- 2. The reference level for timing of input signals is 1.4V.
- 3. Output load.



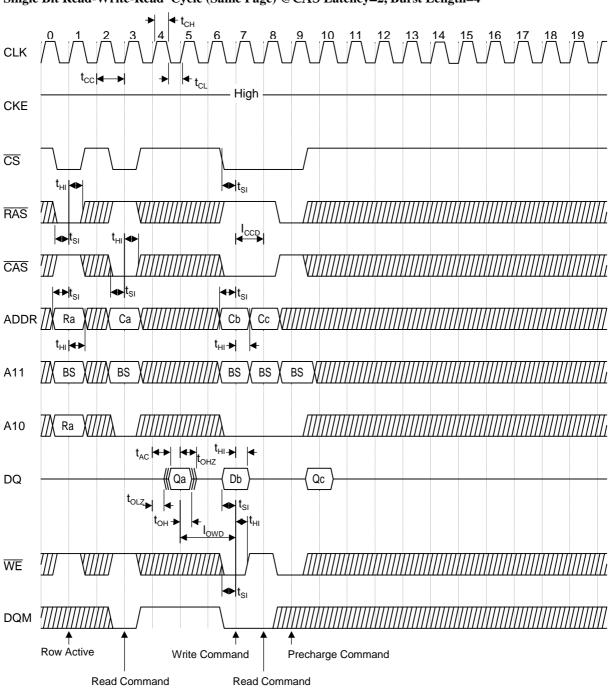
4. The access time is defined at 1.4V.

5. If t_T is longer than 1ns, then the reference level for timing of input signals is V_{IH} and V_{IL} .

TIMING CHART



Read & Write Cycle (Same Bank) @ CAS Latency=2, Burst Length=4



Single Bit Read-Write-Read Cycle (Same Page) @ CAS Latency=2, Burst Length=4

FEDD56V16800F-01

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MSM56V16800F

- *Note: 1. When \overline{CS} is set "High" at a clock transition from "Low" to "High", all inputs except CKE and DQM are invalid.
 - 2. When issuing an active, read or write command, the bank is selected by A11.

A11	Active, read or write
0	Bank A
1	Bank B

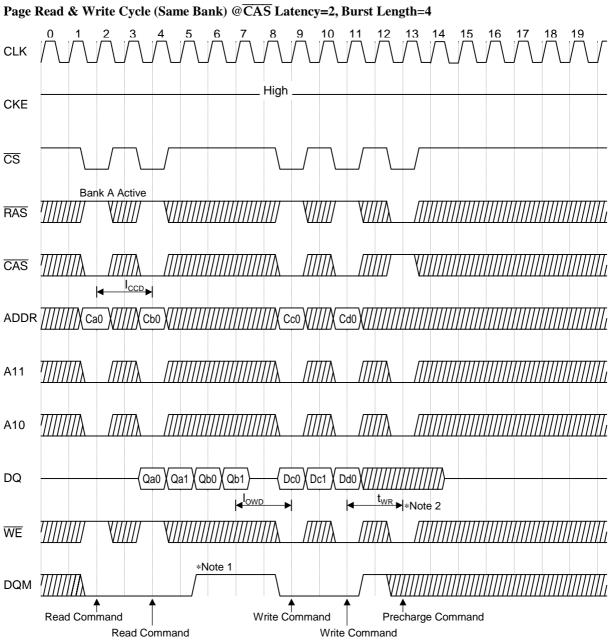
3. The auto precharge function is enabled or disabled by the A10 input when the read or write command is issued.

A10	A11	Operation
0	0	After the end of burst, bank A holds the idle status.
1	0	After the end of burst, bank A is precharged automatically.
0	1	After the end of burst, bank B holds the idle status.
1	1	After the end of burst, bank B is precharged automatically.

4. When issuing a precharge command, the bank to be precharged is selected by the A10 and A11 inputs.

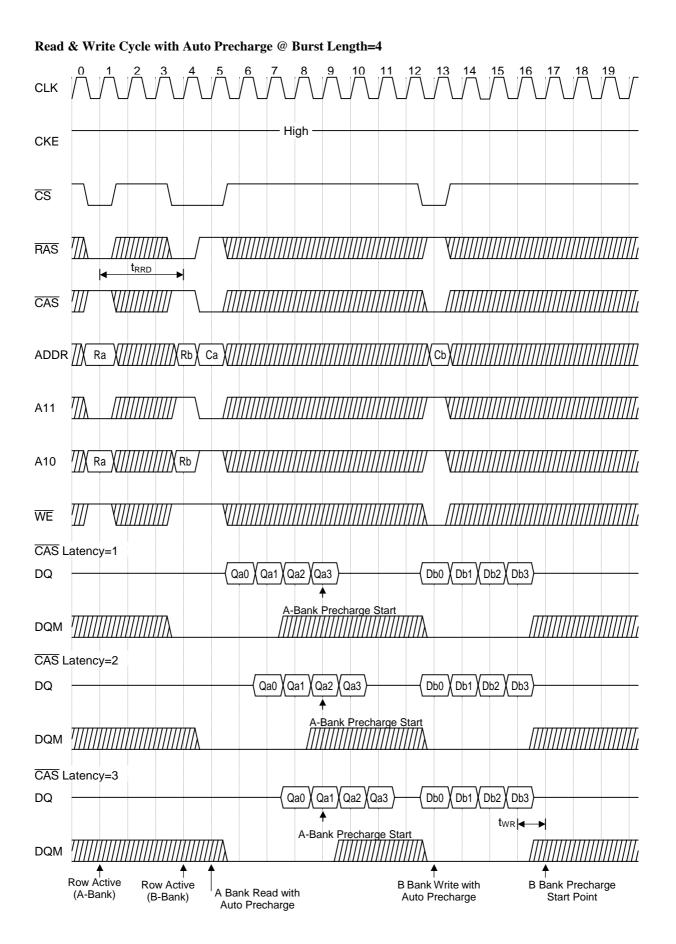
A10	A11	Operation			
0	0	Bank A is precharged.			
0	1	Bank B is precharged.			
1	Х	Both banks A and B are precharged.			

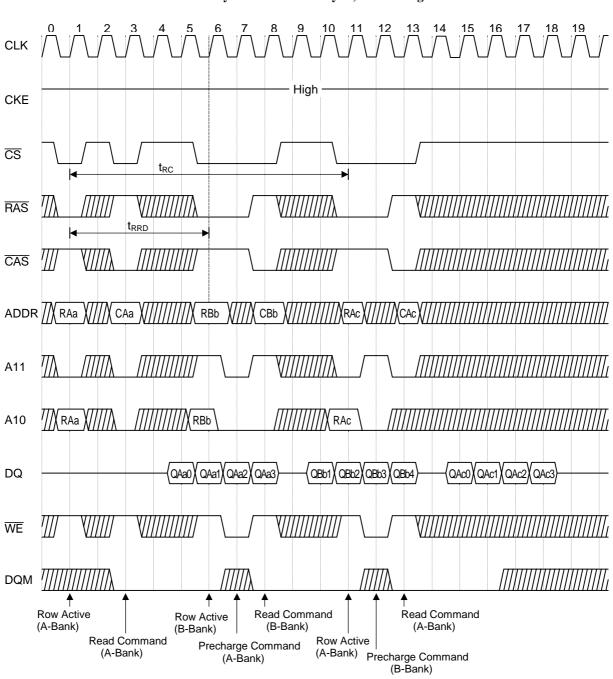
- 5. The input data and the write command are latched by the same clock (Write latency=0).
- 6. The output is forced to high impedance by $(1CLK + t_{OHZ})$ after DQM entry.



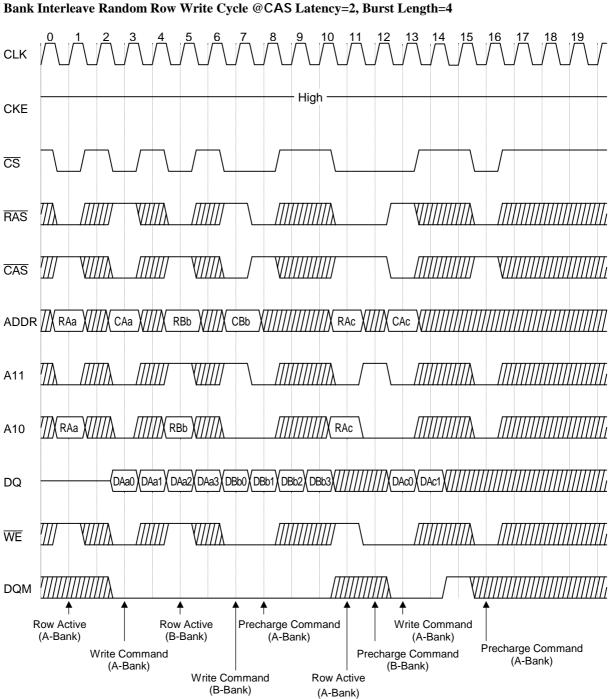
*Note: 1. To write data before a burst read ends, DQM should be asserted three cycles prior to the write command to avoid bus contention.

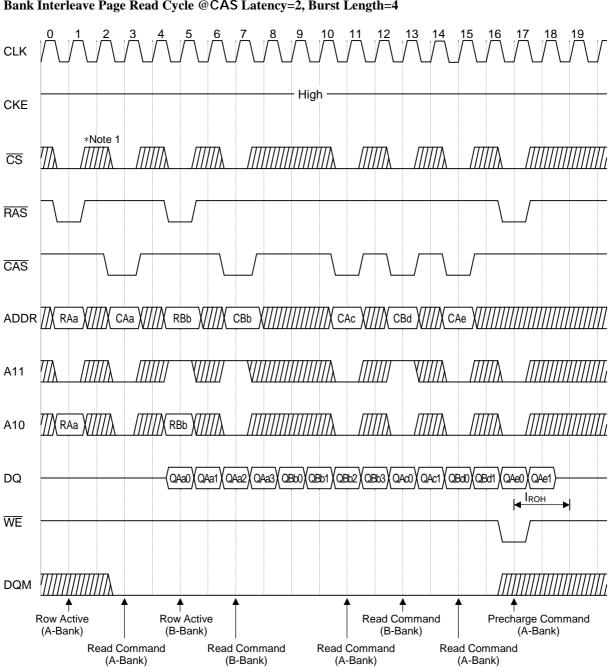
2. To assert row precharge before a burst write ends, wait t_{WR} after the last write data input. Input data during the precharge input cycle will be masked internally.





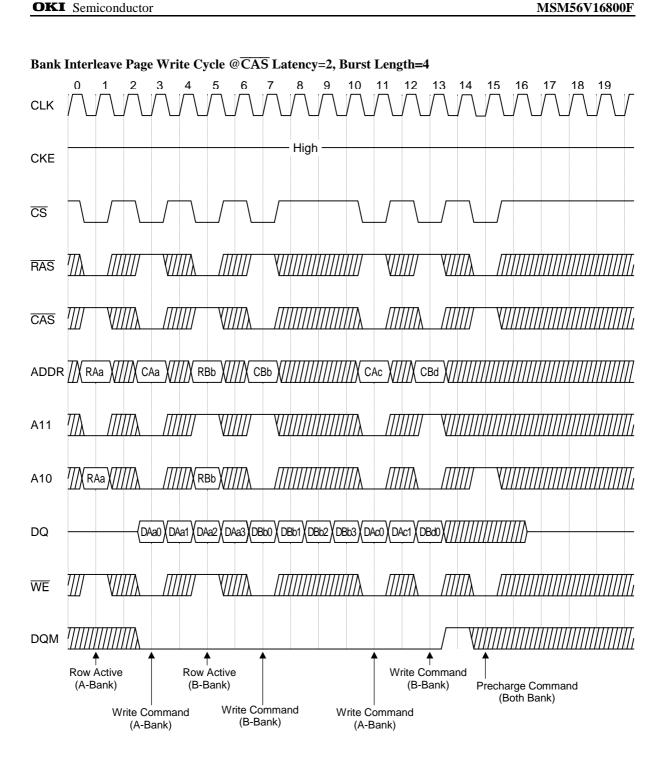
Bank Interleave Random Row Read Cycle @CAS Latency=2, Burst Length=4

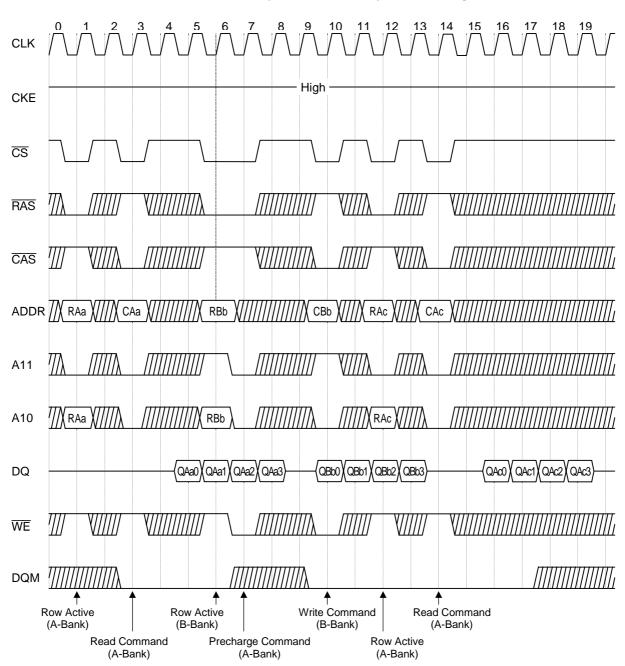




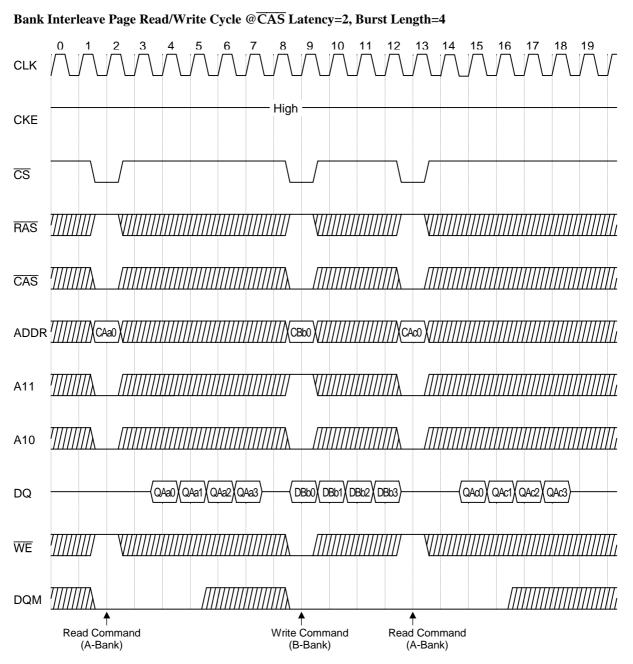
Bank Interleave Page Read Cycle @CAS Latency=2, Burst Length=4

*Note: 1. \overline{CS} is ignored when \overline{RAS} , \overline{CAS} and \overline{WE} are high at the same cycle.





Bank Interleave Random Row Read/Write Cycle @CAS Latency=2, Burst Length=4



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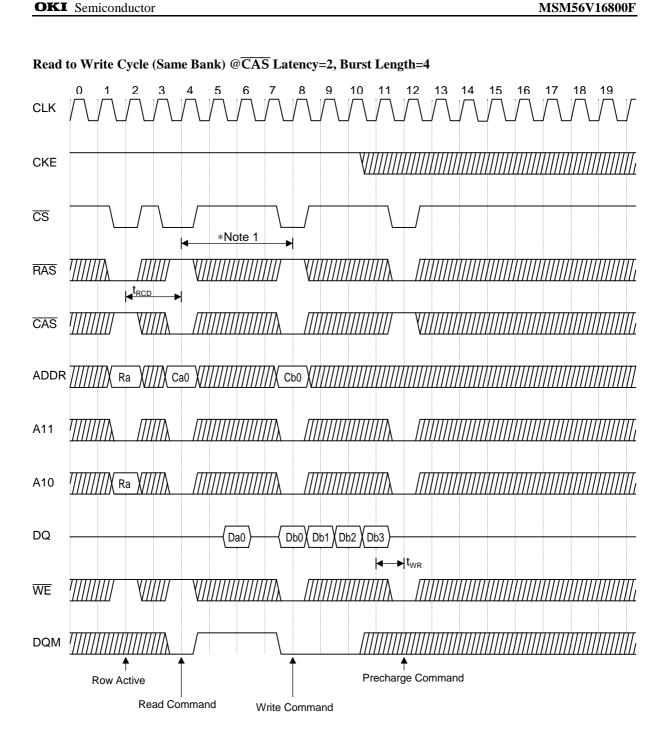
MSM56V16800F

Clock Suspension & DQM Operation Cycle @ CAS Latency=2, Burst Length=4 12 15 18 9 10 11 13 14 16 17 19 3 5 6 8 CLK Ø *Note 1 *Note 1 CKE V//// CS V//// RAS V//// []CAS ADDR //// Ra Са Cb Сс A11 /// Ra A10 Qa0 XQa1 Qa2 Qb0 X Qb1 Dc0 Dc2 DQ *Note 3 t_{OHZ} t_{OHZ} |◀ ► *Note 2 MWE V//// VI. /// DQM CLOCK Write Write DQM Read Command Read DQM Row Active Suspension DQM Read Command Write **CLOCK Suspension** Read DQM Command

*Note: 1. When Clock Suspension is asserted, the next clock cycle is ignored.

2. When DQM are asserted, the read data after two clock cycles is masked.

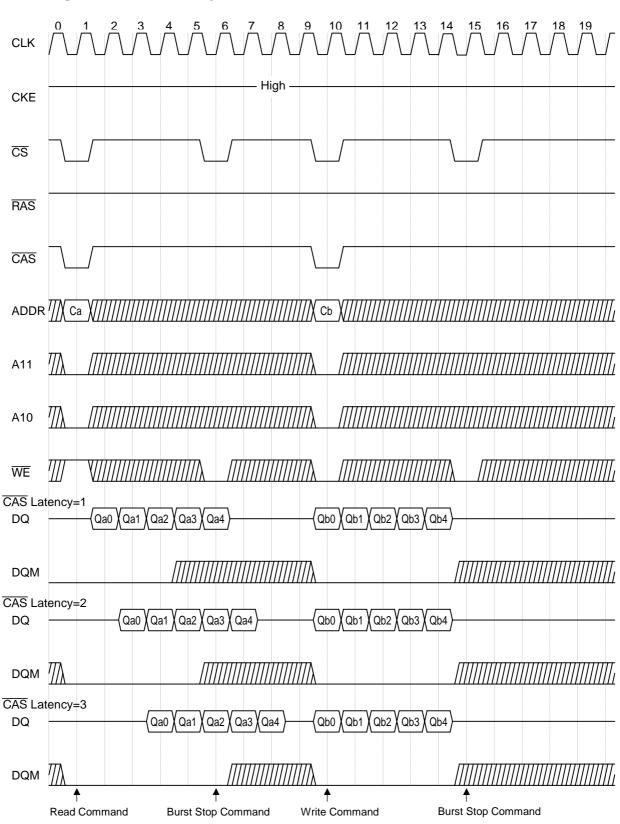
3. When DQM are asserted, the write data in the same clock cycle is masked.



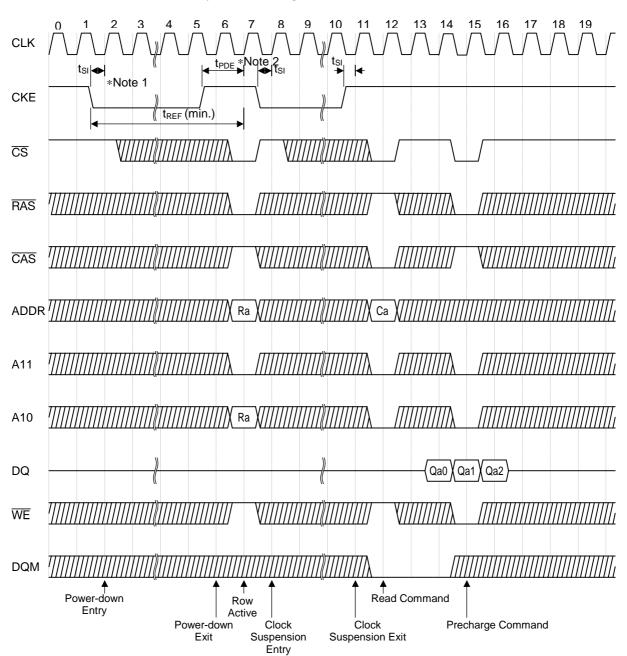
*Note: 1. In Case \overline{CAS} latency is 3, READ can be interrupted by WRITE. The minimum command interval is [burst length + 1] cycles. DQM must be high at least 3 clocks prior to the write command.

Read Interruption by Precharge Command @Burst Length=8 11 CLK High CKE CS RAS CAS ADDR // Ra Са A11 A10 Ra η WE V/ CAS Latency=1 *Note 1 DQ Qa0 X Qa1 X Qa2 X Qa3 X Qa4 X Qa5 DQM CAS Latency=2 *Note 1 DQ Qa0 XQa1 (Qa3) Qa4 Qa5 Qa2 ROH DQM CAS Latency=3 *Note 1 DQ Qa0 X Qa1 X Qa2 Qa3 🛛 Qa4 🖉 Qa5 IROH DQM llh4 Row Active Read Command Precharge Command

*Note: 1. if row precharge is asserted before a burst read ends, then the read data will not output after l_{ROH} equals \overline{CAS} latency.



Burst Stop Command @Burst Length=8



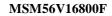
Power Down Mode @CAS Latency=2, Burst Length=4

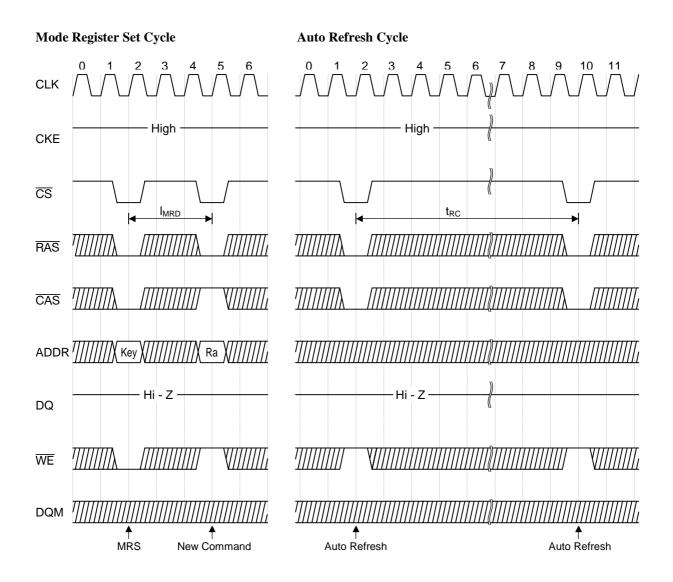
2. To release the circuit from power-down mode, CKE has to be set high for longer than $t_{PDE}(t_{SI} + 1CLK)$.

^{*}Note: 1. When both banks are in precharge state, and if CKE is set low, then the MSM56V16800F enters power-down mode and maintains the mode while CKE is low.

Self Refresh Cycle

CLK		
CKE		
CS		
RAS	777777777777777777777777777777777777777	
CAS	ттттх (птттттттттттттттт	
ADDR		/////////Ra \///////////////////////////
A11		/////////////////////////////////////
A10	<u>,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,</u>	//////////////////////////////////////
DQ	————— Hi-Z –	
WE		
DQM		
	↑ Self Refresh Entry	Self Refresh Exit Row Active





Current State ¹	$\overline{\text{CS}}$	RAS	CAS	WE	BA	ADDR	Action		
Idle	Н	Х	Х	Х	Х	Х	NOP		
	L	Н	Н	Н	Х	Х	NOP		
	L	Н	Н	L	BA	Х	ILLEGAL ²		
	L	Н	L	Х	BA	CA	ILLEGAL ²		
	L	L	Н	Н	BA	RA	Row Active		
	L	L	Н	L	BA	A10	NOP ⁴		
	L	L	L	Н	Х	Х	Auto-Refresh or Self-Refresh 5		
	L	L	L	L	L	OP Code	Mode Register Write		
Row Active	Н	Х	Х	Х	Х	Х	NOP		
	L	Н	Н	Х	Х	Х	NOP		
	L	Н	L	Н	BA	CA, A10	Read		
	L	Н	L	L	BA	CA, A10	Write		
	L	L	Н	Н	BA	RA	ILLEGAL ²		
	L	L	Н	L	BA	A10	Precharge		
	L	L	L	Х	Х	Х	ILLEGAL		
Read	Н	Х	Х	Х	Х	Х	NOP (Continue Row Active after Burst ends)		
	L	Н	Н	Н	Х	Х	NOP (Continue Row Active after Burst ends)		
	L	Н	Н	L	Х	Х	Term Burst> Row Active		
	L	Н	L	Н	BA	CA, A10	Term Burst, start new Burst Read ³		
	L	Н	L	L	BA	CA, A10	Term Burst, start new Burst Write ³		
	L	L	Н	Н	BA	RA	ILLEGAL ²		
	L	L	Н	L	BA	A10	Term Burst, execute Row Precharge		
	L	L	L	Х	Х	Х	ILLEGAL		
Write	Н	Х	Х	Х	Х	Х	NOP (Continue Row Active after Burst ends)		
	L	Н	Н	Н	Х	Х	NOP (Continue Row Active after Burst ends)		
	L	Н	Н	L	Х	Х	Term Burst> Row Active		
	L	Н	L	Н	BA	CA, A10	Term Burst, start new Burst Read 3		
	L	Н	L	L	BA	CA, A10	Term Burst, start new Burst Write ³		
	L	L	Н	Н	BA	RA	ILLEGAL ²		
	L	L	Н	L	BA	A10	Term Burst, execute Row Precharge ³		
	L	L	L	Х	Х	Х	ILLEGAL		
Read with	Н	Х	Х	Х	Х	Х	NOP (Continue Burst to End and enter Row Precharge)		
Auto Precharge	L	Н	Н	Н	Х	Х	NOP (Continue Burst to End and enter Row Precharge)		
riconargo	L	Н	Н	L	BA	Х	ILLEGAL 2		
	L	Н	L	Н	BA	CA, A10	ILLEGAL ²		
	L	H	L	L	Х	Х	ILLEGAL		
		L	H	Х	BA	RA, A10	ILLEGAL 2		
	L	L	L	Х	Х	Х	ILLEGAL		
Write with	Н	Х	Х	Х	Х	Х	NOP (Continue Burst to End and enter Row Precharge		
Auto Precharge	L	Н	Н	Н	Х	Х	NOP (Continue Burst to End and enter Row Precharge		
· · · · · · · · · · · · · · · · · · · ·	L	Н	Н	L	BA	Х	ILLEGAL 2		
	L	Н	L	Н	BA	CA, A10	ILLEGAL ²		

FUNCTION TRUTH TABLE (Table 1) (1/2)

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Current State ¹	CS	RAS	CAS	WE	BA	ADDR	Action		
Write with	L	Н	L	L	Х	Х	ILLEGAL		
Auto	L	L	Н	Х	BA	RA, A10	ILLEGAL ²		
Precharge	L	L	L	Х	Х	Х	ILLEGAL		
Precharge	Н	Х	Х	Х	Х	Х	NOP> Idle after t _{RP}		
	L	Н	Н	Н	Х	Х	NOP> Idle after t _{RP}		
	L	Н	Н	L	BA	Х	ILLEGAL ²		
	L	Н	L	Х	BA	CA	ILLEGAL ²		
	L	L	Н	Н	BA	RA	ILLEGAL ²		
	L	L	Н	L	BA	A10	NOP ⁴		
	L	L	L	Х	Х	Х	ILLEGAL		
Write	Н	Х	Х	Х	Х	Х	NOP		
Recovery	L	Н	Н	Н	Х	Х	NOP		
	L	Н	Н	L	BA	Х	ILLEGAL ²		
	L	Н	L	Х	BA	CA	ILLEGAL ²		
	L	L	Н	Н	BA	RA	ILLEGAL ²		
	L	L	Н	L	BA	A10	ILLEGAL ²		
	L	L	L	Х	Х	Х	ILLEGAL		
Row Active	Н	Х	Х	Х	Х	Х	NOP> Row Active after t _{RCD}		
	L	Н	Н	Н	Х	Х	NOP> Row Active after t _{RCD}		
	L	Н	Н	L	BA	Х	ILLEGAL ²		
	L	Н	L	Х	BA	CA	ILLEGAL 2		
	L	L	Н	Н	BA	RA	ILLEGAL ²		
	L	L	Н	L	BA	A10	ILLEGAL ²		
	L	L	L	Х	Х	Х	ILLEGAL		
Refresh	Н	Х	Х	Х	Х	Х	NOP> Idle after t _{RC}		
	L	Н	Н	Х	Х	Х	NOP> Idle after t _{RC}		
	L	Н	L	Х	Х	Х	ILLEGAL		
	L	L	Н	Х	Х	Х	ILLEGAL		
	L	L	L	Х	Х	Х	ILLEGAL		
Mode	Н	Х	Х	Х	Х	Х	NOP		
Register	L	Н	Н	Н	Х	Х	NOP		
Access	L	Н	Н	L	Х	Х	ILLEGAL		
	L	Н	L	Х	Х	Х	ILLEGAL		
	L	L	Х	Х	Х	Х	ILLEGAL		

FUNCTION TRUTH TABLE (Table 2) (2/2)

ABBREVIATIONS

RA = Row Address BA = Bank Address NOP = No OPeration command

CA = Column Address AP = Auto Precharge

*Notes :1. All inputs are enabled when CKE is set high for at least 1 cycle prior to the inputs.

- 2. Illegal to bank in specified state, but may be legal in some cases depending on the state of bank selection.
 - 3. Satisfy the timing of l_{CCD} and t_{WR} to prevent bus contention.
 - 4. NOP to bank precharging or in idle state. Precharges activated bank by BA or A10.
 - 5. Illegal if any bank is not idle.

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Current State (n)	CKEn-1	CKEn	CS	RAS	CAS	WE	ADDR	Action
Self Refresh	Н	Х	Х	Х	Х	Х	Х	INVALID
	L	Н	Н	Х	Х	Х	Х	Exit Self Refresh> ABI
	L	Н	L	Н	Н	Н	Х	Exit Self Refresh> ABI
	L	Н	L	Н	Н	L	Х	ILLEGAL
	L	Н	L	Н	L	Х	Х	ILLEGAL
	L	Н	L	L	Х	Х	Х	ILLEGAL
	L	L	Х	Х	Х	Х	Х	NOP (Maintain Self Refresh)
Power Down	Н	Х	Х	Х	Х	Х	Х	INVALID
	L	Н	Н	Х	Х	Х	Х	Exit Power Down> ABI
	L	Н	L	Н	Н	Н	Х	Exit Power Down> ABI
	L	Н	L	Н	Н	L	Х	ILLEGAL
	L	Н	L	Н	L	Х	Х	ILLEGAL
	L	Н	L	L	Х	Х	Х	ILLEGAL ⁶
	L	L	Х	Х	Х	Х	Х	NOP (Continue power down mode)
All Banks Idle 6	Н	Н	Х	Х	Х	Х	Х	Refer to Table 1
(ABI)	Н	L	Н	Х	Х	Х	Х	Enter Power Down
	Н	L	L	Н	Н	Н	Х	Enter Power Down
	Н	L	L	Н	Н	L	Х	ILLEGAL
	Н	L	L	Н	L	Х	Х	ILLEGAL
	Н	L	L	L	Н	L	Х	ILLEGAL
	Н	L	L	L	L	Н	Х	Enter Self Refresh
	Н	L	L	L	L	L	Х	ILLEGAL
	L	L	Х	Х	Х	Х	Х	NOP
Any State Other	Н	Н	Х	Х	Х	Х	Х	Refer to Operations in Table 1
than Listed	Н	L	Х	Х	Х	Х	Х	Begin Clock Suspend Next Cycle
Above	L	Н	Х	Х	Х	Х	Х	Enable Clock of Next Cycle
	L	L	Х	Х	Х	Х	Х	Continue Clock Suspension

FUNCTION TRUTH TABLE for CKE (Table 2)

*Notes :6. Power-down and self-refresh can be entered only when all the banks are in an idle state.

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